Product data sheet

1. General description

Silicon Carbide MOSFET in a TO263-7L plastic package, designed for high frequency, high efficiency systems.



2. Features and benefits

- · Kelvin source configuration
- Low on-resistance
- Fast switching speed
- 0V turn-off V_{GS} for simple gate driving
- 100% UIS Tested
- Easy to parallel
- RoHS compliant

3. Applications

- · Automotive on board chargers
- Automotive DC-DC converters
- · Automotive electric compressor motor drives
- · HV battery management systems

4. Quick reference data

Table 1. Quick reference data

	Donomotor	Conditions	Notes		Values		1114
Symbol	Parameter	Conditions	Notes	Values		Unit	
Absolute	maximum rating						
V_{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C			1200		V
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C			43		А
P _{tot}	total power dissipation	T _{mb} = 25 °C, T _j = 175 °C			234		W
T _j	junction temperature			-55 to 175		°C	
Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
$R_{\text{DS(on)}}$	drain-source on-state resistance	$V_{GS} = 15 \text{ V}; I_D = 20 \text{ A}; T_j = 25 ^{\circ}\text{C}$		-	75	-	mΩ
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_D = 20 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	63	-	nC
Q_{GD}	gate-drain charge	T _j = 25 °C		-	11	-	nC
Source-di	rain diode				'	,	
Q_r	recovered charge	I_{SD} = 20 A; di/dt = 500 A/µs; V_{DS} = 400 V; T_j = 25 °C		-	49	-	nC

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	SS	source sense		
3-7	S	source		G_(15)
mb	D	mounting base; connected to drain	TO263-7L	SS Sym301 S

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WNSC2M75120B7-A	TO263-7L	WNSC2M75120B7-A6J	Reel	800	TO263P-7L	12-Jun-2023

7. Marking

Table 4. Marking codes

Type number	Marking codes
WNSC2M75120B7-A	WNSC2M 75120B7-A

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		1200	V
$V_{\rm GS,max}$	gate-source voltage			-10 to 22	V
$V_{GS,op}$	gate-source voltage			-4 to 18	V
P _{tot}	total power dissipation	T _{mb} = 25 °C, T _j = 175 °C		234	W
I _D	drain current	V _{GS} = 18 V; T _{mb} = 25 °C		43	Α
		V _{GS} = 18 V; T _{mb} = 100 °C		30	Α
I _{DM}	peak drain current	pulse width t _p limited by T _{jmax}	Fig.17	86	Α
Is	continuous diode current	V _{GS} = -4 V; T _{mb} = 25 °C		40	Α
I _{SM}	pulse diode current	V_{GS} = -4 V; pulse width t_p limited by T_{jmax}		86	А
E _{as}	single pulse drain-to- source avalanche	I_{AS} = 15 A; L = 1 mH; V_{DD} = 100 V; T_j = 25 °C		113	mJ
T _{stg}	storage temperature			-55 to 175	°C
T _j	junction temperature			-55 to 175	°C
$T_{sld(M)}$	peak soldering temperature			260	°C

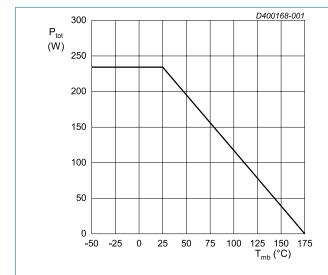


Fig. 1. Total power dissipation as a function of mounting base temperature; maximum values

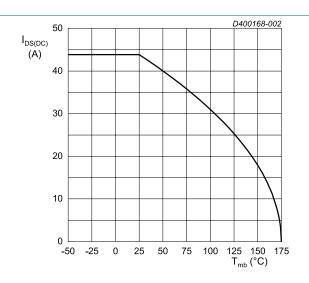


Fig. 2. Continuous Drain Current as a function of mounting base temperature

9. Thermal & Mechanical characteristics

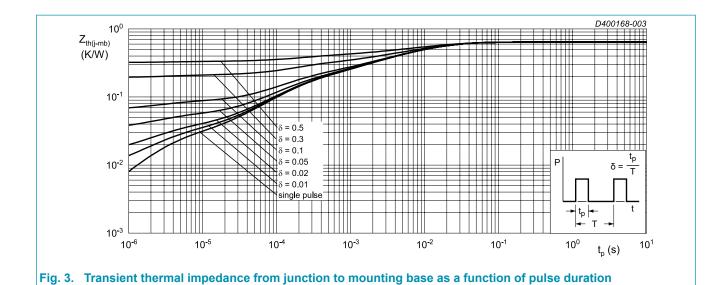
Table 6. Thermal & Mechanical characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
$R_{\text{th(j-mb)}}$	thermal resistance from junction to mounting base			-	0.64	-	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W

Note: It is recommended that a metal washer is inserted between screw head and mounting tab.

Do not use self-tapping screws.

Device is ESD sensitive. Handling precautions are recommanded.



10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Тур	Max	Unit
Static cha	racteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 100 \mu A; V_{GS} = 0 V; T_j = 25 °C$		1200	-	-	V
$V_{GS(th)}$	gate-source threshold	$I_D = 5 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 25 \text{ °C}$		1.8	2.2	3.5	V
	voltage	$I_D = 5 \text{ mA}; V_{DS} = 10 \text{ V}; T_j = 175 ^{\circ}\text{C}$		-	1.5	-	V
I _{DSS}	drain leakage current	$V_{DS} = 1200 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$		-	0.2	100	μA
		V _{DS} = 1200 V; V _{GS} = 0 V; T _j = 175 °C		-	2	-	μΑ
I _{GSS}	gate leakage current	V _{GS} = 24 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
		V _{GS} = -12 V; V _{DS} = 0 V; T _j = 25 °C		-	10	100	nA
R _{DS(on)}	drain-source on-state	V _{GS} = 15 V; I _D = 20 A; T _j = 25 °C		-	75	-	mΩ
	resistance	V _{GS} = 18 V; I _D = 20 A; T _j = 25 °C		-	64	90	mΩ
		V _{GS} = 18 V; I _D = 20 A; T _j = 175 °C		-	122	-	mΩ
R _G	gate resistance	f = 1 MHz; T _j = 25 °C		-	2.5	-	Ω
g _{fs}	transconductance	$V_{DS} = 20 \text{ V}; I_{D} = 20 \text{ A}; T_{j} = 25 \text{ °C}$		-	11.5	-	S
Dynamic	characteristics						
Q _{G(tot)}	total gate charge	$I_D = 20 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$		-	63	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C		-	25	-	nC
Q_{GD}	gate-drain charge			-	11	-	nC
C _{iss}	input capacitance	V _{DS} = 1000 V; V _{GS} = 0 V; f = 1 MHz;		-	1347	-	pF
C _{oss}	output capacitance	T _j = 25 °C		-	58	-	pF
C _{rss}	reverse transfer capacitance			-	4.6	-	pF
E _{oss}	Coss stored energy			-	29	-	μJ
t _{d(on)}	turn-on delay time	$V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V}; R_{G(ext)} = 5.1$		-	17	-	ns
t _r	rise time	Ω ; $I_D = 20 \text{ A}$; $L = 300 \mu\text{H}$; $T_j = 25 \text{ °C}$		-	7	-	ns
$t_{d(off)}$	turn-off delay time			-	35	-	ns
t _f	fall time			-	15	-	ns
E _{on}	turn-on energy (Body Diode FWD)		Fig.20	-	97	-	μJ
E _{off}	turn-off energy (Body Diode FWD)		Fig.20	-	66	-	μJ
Source-di	ain diode						
V _{SD}	source-drain voltage	V _{GS} = 0 V; I _{SD} = 10 A; T _i = 25 °C		-	3.2	-	V
		V _{GS} = -4 V; I _{SD} = 10 A; T _j = 25 °C		-	4.8	-	V
		$V_{GS} = -4 \text{ V; } I_{SD} = 10 \text{ A; } T_j = 175 \text{ °C}$		-	4.2	-	V
t _{rr}	reverse recovery time	I_{SD} = 20 A; di/dt = 500 A/µs; V_{DS} = 400 V;		-	21	-	ns
Q _r	recovered charge	T _j = 25 °C		-	49	-	nC
I _{rrm}	reverse recovery current			_	4.25	_	Α

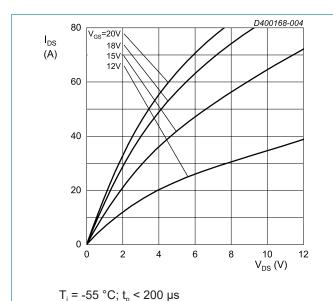
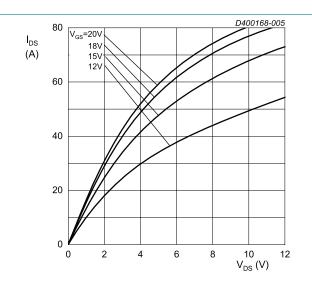
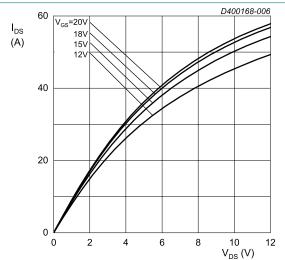


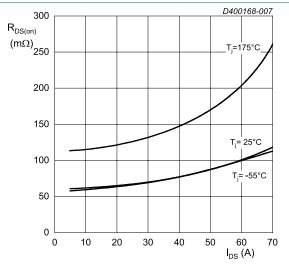
Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



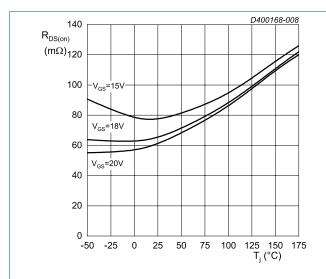
T_j = 25 °C; t_p < 200 μs Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



T_j = 175 °C; t_p < 200 μs Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

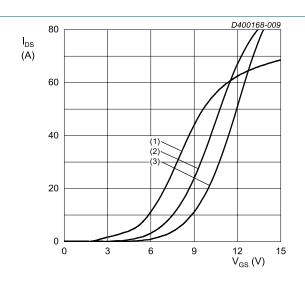


 V_{GS} = 18 V; t_p < 200 µs Fig. 7. Drain-source on-state resistance as a function of drain current; typical values



 I_{DS} = 20 A; t_p < 200 μs

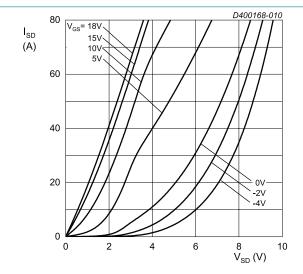
Fig. 8. Drain-source on-state resistance as a function of junction temperature



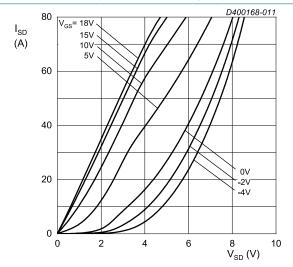
 $V_{DS} = 20 \text{ V; } t_p < 200 \text{ } \mu \text{s}$ (1) $T_j = 175 \text{ }^{\circ}\text{C}$ (2) $T_j = 25 \text{ }^{\circ}\text{C}$

(3) $T_i = -55 \,^{\circ}C$

Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values

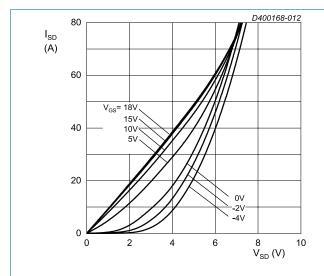


 $T_{j} = -55 \, ^{\circ}\text{C}; t_{p} < 200 \, \mu\text{s}$ Fig. 10. Body diode forward characteristics; typical values

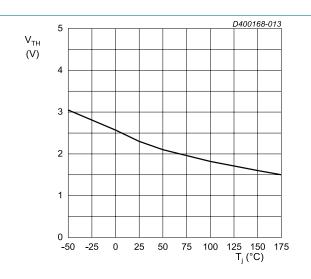


 $T_{j} = 25 \, ^{\circ}\text{C}; t_{p} < 200 \, \mu\text{s}$

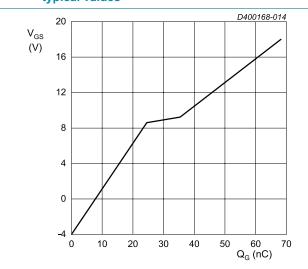
Fig. 11. Body diode forward characteristics; typical values



 T_{j} = 175 °C; t_{p} < 200 µs Fig. 12. Body diode forward characteristics; typical values



V_{DS} = 10 V; I_{DS} = 5 mA Fig. 13. Threshold voltage as a function of junction temperature



I_{DS} = 20 A; I_{GS} = 0.1 mA; V_{DS} = 800 V; T_j = 25 °C Fig. 14. Gate-source voltage as a function of gate charge; typical values

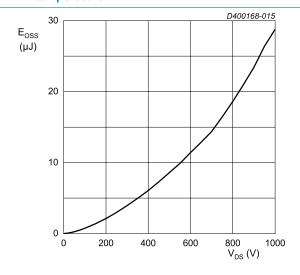
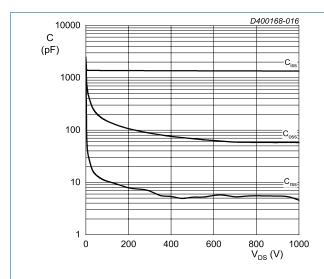


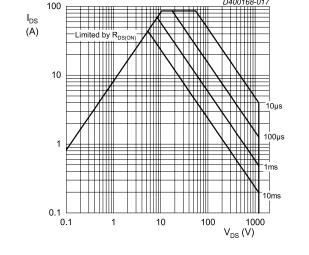
Fig. 15. Output capacitor stored energy as a function of drain-source voltage

D400168-017

N-Channel Silicon Carbide MOSFET

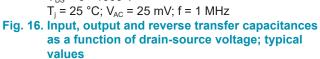


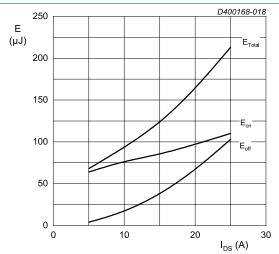
 $V_{DS} = 0 - 1000 V$



 $T_i = 25 \,^{\circ}C; D = 0$ Parameter: t₀

Fig. 17. Forward bias safe operating area

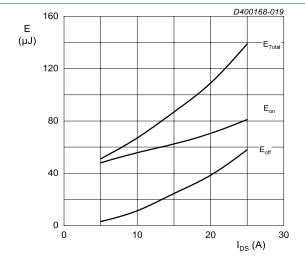




 T_{j} = 25 °C; V_{DD} = 800 V; $R_{G(ext)}$ = 5.1 $\Omega;$ V_{GS} = -4 V/18 V; L = 300 μH

FWD = WNSC2M75120B7-A

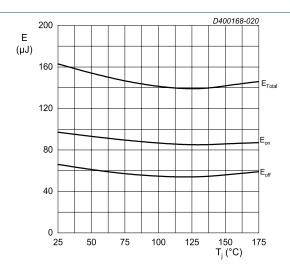
Fig. 18. Clamped Inductive Switching Energy as a function of drain current



 T_{j} = 25 °C; V_{DD} = 600 V; $R_{G(ext)}$ = 5.1 $\Omega;$ V_{GS} = -4 V/18 V; L = 300 μH

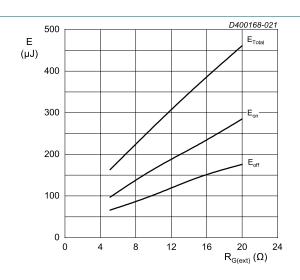
FWD = WNSC2M75120B7-A

Fig. 19. Clamped Inductive Switching Energy as a function of drain current



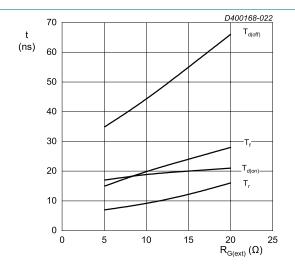
$$\begin{split} I_{DS} &= 20 \text{ A; V}_{DD} = 800 \text{ V; R}_{G(ext)} = 5.1 \text{ }\Omega; \\ V_{GS} &= -4 \text{ V}/18 \text{ V; L} = 300 \text{ }\mu\text{H} \\ FWD &= WNSC2M75120B7-A \end{split}$$

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



 $T_{\rm j}$ = 25 °C; $V_{\rm DD}$ = 800 V; $I_{\rm DS}$ = 20 A; $V_{\rm GS}$ = -4 V/18 V FWD = WNSC2M75120B7-A; L = 300 μH

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



 $T_{j}=25~^{\circ}C;~V_{DD}=800~V;~I_{DS}=20~A;~V_{GS}=-4~V/18~V$ $FWD=WNSC2M75120B7-A;~L=300~\mu H$ Fig. 22. Switching time as a function of external gate

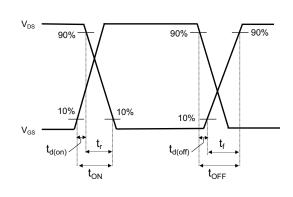
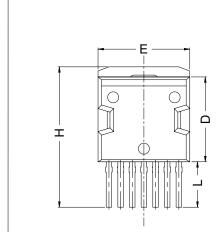
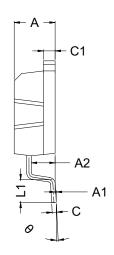


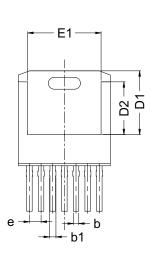
Fig. 23. Switching time definition

resistance

11. Package outline

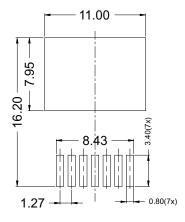






Dim	All Dimensions in Millimeters				
Dilli	Min	Тур	Max		
Α	4.30	4.46	4.60		
A1	0	0.13	0.25		
A2	2.50	2.60	2.70		
b	0.50	0.60	0.70		
b1	0.50	0.70	0.90		
С	0.40	0.52	0.60		
C1	1.17	1.29	1.40		
D	9.00	9.25	9.50		
D1	6.80	6.95	7.10		
D2	5.60	5.75	5.90		
E	9.80	10.00	10.20		
E1	7.90	8.00	8.10		
е	1.27 BSC				
Н	14.60	15.30	16.00		
L	4.50	4.95	5.40		
L1	2.10	2.47	2.80		
θ	0°	4°	8°		

Footprint:



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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For more information, please visit: http://www.ween-semi.com For sales office addresses, please send an email to: salesaddresses@ween-semi.com Date of release: 26 September 2024

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